SCAS552A - NOVEMBER 1995 - REVISED MAY 1996

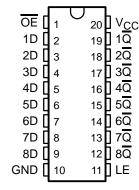
- 3-State Inverting Outputs Drive Bus Lines Directly
- Full Parallel Access for Loading
- Flow-Through Architecture to Optimize PCB Layout
- EPIC[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPs

description

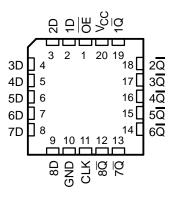
The 'AC563 are octal D-type transparent latches with 3-state outputs. When the latch-enable (LE) input is high, the \overline{Q} outputs follow the complements of the data (D) inputs. When LE is taken low, the \overline{Q} outputs are latched at the inverse logic levels set up at the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

SN54AC563 . . . J OR W PACKAGE SN74AC563 . . . DB, DW, N, OR PW PACKAGE (TOP VIEW)



SN54AC563 . . . FK PACKAGE (TOP VIEW)



OE does not affect internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54AC563 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74AC563 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE (each latch)

	(,	
	INPUTS	OUTPUT	
OE	LE	D	Q
L	Н	Н	L
L	Н	L	Н
L	L	Χ	\overline{Q}_0
Н	Χ	Х	Z



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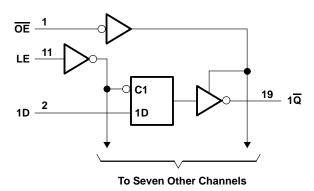
SN54AC563, SN74AC563 OCTAL D-TYPE TRANSPARENT LATCHES WITH 3-STATE OUTPUTS

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logic symbol†

ΘĒ ΕN LE C1 2 19 1Q 1▷ 1D 1D 18 3 2D $2\overline{Q}$ 17 4 3<u>Q</u> 3D 16 5 4D 4Q 15 6 5D 5Q 7 14 6D 6Q 8 13 7D 7Q 12 9 8Q 8D

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}		–0.5 V to 7 V
Input voltage range, V _I (see Note 1)		-0.5 V to V _{CC} + 0.5 V
Output voltage range, VO (see Note 1)		$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)		$\dots \dots \pm 20 \text{ mA}$
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})		$\dots \dots \pm 20 \text{ mA}$
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$		$\dots \dots \pm 50 \text{ mA}$
Continuous current through V _{CC} or GND		$\dots \dots \pm 200 \text{ mA}$
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2):	DB package	0.6 W
	DW package	1.6 W
	N package	1.3 W
	PW package	0.7 W
Storage temperature range, T _{stq}		65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

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recommended operating conditions (see Note 3)

			SN54A	SN54AC563		SN74AC563		
			MIN	MAX	MIN	MAX	UNIT	
VCC	Supply voltage		2	6	2	6	V	
		V _{CC} = 3 V	2.1		2.1			
V_{IH}	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15		3.15		V	
		$V_{CC} = 5.5 \text{ V}$	3.85		3.85			
		V _{CC} = 3 V		0.9		0.9		
V_{IL}	Low-level input voltage	$V_{CC} = 4.5 \text{ V}$		1.35		1.35	V	
		$V_{CC} = 5.5 \text{ V}$		1.65		1.65		
٧ _I	Input voltage		0′	VCC	0	VCC	V	
٧o	Output voltage		9	VCC	0	VCC	V	
		V _{CC} = 3 V	80	-12		-12		
loh	High-level output current	$V_{CC} = 4.5 \text{ V}$	4	-24		-24	mA	
		$V_{CC} = 5.5 \text{ V}$		-24		-24		
		$V_{CC} = 3 V$		12		12		
loL	Low-level output current	V _{CC} = 4.5 V		24		24	mA	
		V _{CC} = 5.5 V		24		24		
Δt/Δν	Input transition rise or fall rate			8		8	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS		Т	A = 25°C	;	SN54A	C563	SN74AC563		LINUT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		3 V	2.99			2.9		2.9		
	I _{OH} = -50 μA	4.5 V	4.49			4.4		4.4		
		5.5 V	5.49			5.4		5.4		
Voн	I _{OH} = -12 mA	3 V	2.56			2.48		2.46		V
	Jan. 24 mA	4.5 V	3.86			3.8	h	3.76		
	I _{OH} = -24 mA	5.5 V	4.86			4.8	VIE	4.76		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85	PRE	3.85		
	I _{OL} = 50 μA	3 V		0.002	0.1		0.1		0.1	
		4.5 V		0.001	0.1	3	0.1		0.1	
		5.5 V		0.001	0.1	30/	0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36	d	0.5		0.44	V
	lo 24 mA	4.5 V			0.36		0.5		0.44	
	I _{OL} = 24 mA	5.5 V			0.36		0.5		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65		1.65	
lį	V _I = V _{CC} or GND	5.5 V			±0.1		±1		±1	μΑ
loz	V _O = V _{CC} or GND	5.5 V			±0.5		±5		±5	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8				80	μΑ
C _i	$V_I = V_{CC}$ or GND	5 V		4.5						pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.



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timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54AC563 SN74AC		C563	UNIT
		MIN	MAX	MIN MAX	MIN	MAX	UNIT
t_{W}	Pulse duration, LE high	6		80 44	7		ns
t _{su}	Setup time, data before LE↓	2.5		C5 44	3		ns
t _h	Hold time, data after LE↓	2		2 32	2		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

		T _A = 25°C		SN54AC563 SN74AC563		C563	UNIT
		MIN	MAX	MIN MAX	MIN	MAX	UNIT
t _W	Pulse duration, LE high	4		65 44	5		ns
t _{su}	Setup time, data before LE↓	2		4.5	2.5		ns
th	Hold time, data after LE↓	2		Q 32	2		ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

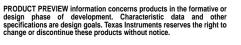
PARAMETER	FROM	то	T,	Վ = 25° C	;	SN54A	C563	SN74A	C563	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	CINIT
^t PLH	D	lα	3.5	5.3	13	1.5	16.5	3.5	15	ns
^t PHL	D	ď	3.5	5.6	12	1.5	15.5	3.5	14	115
^t PLH	LE	Ы	3.5	4.6	13	1.5	16.5	3.5	15	ns
^t PHL	LE	l ^Q	3.5	4.8	12	1.5	15.5	3.5	14	115
^t PZH	1	lα	2.5	5.3	11	1.5	13.5	2.5	12	ns
^t PZL	ŌĒ	Q	3	5.4	11	1.5	14	3.5	12.5	115
t _{PHZ}	ŌĒ	Iα	4	6	12.5	21.5	15	4.5	13.5	20
t _{PLZ}	OE .	y	2	5.1	9.5	1.5	12	2.5	10.5	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	PARAMETER FROM TO		FROM TO T _A = 25°C		;	SN54AC563		SN74AC563		UNIT
PARAIVIETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	D	ıα	2	5.3	10	1.5	13	2	11.5	ns
^t PHL		Q	2	5.6	9.5	1.5	12.5	2	11	115
t _{PLH}	LE	ā	2	4.6	9.5	1.5	12.5	2	11	ns
^t PHL			2	4.8	8.5	1.5	11.5	2	9.5] "15
^t PZH	1	ā	2	5.3	9	1.5	11.5	2	10	20
t _{PZL}	ŌĒ		1.5	5.4	8.5	1.5	11	2	9.5	ns
^t PHZ	ŌĒ	Ια	2	6	11	21.5	13.5	2	12	ns
^t PLZ	OE .	ά	1.5	5.1	8	1.5	10.5	1.5	9	115

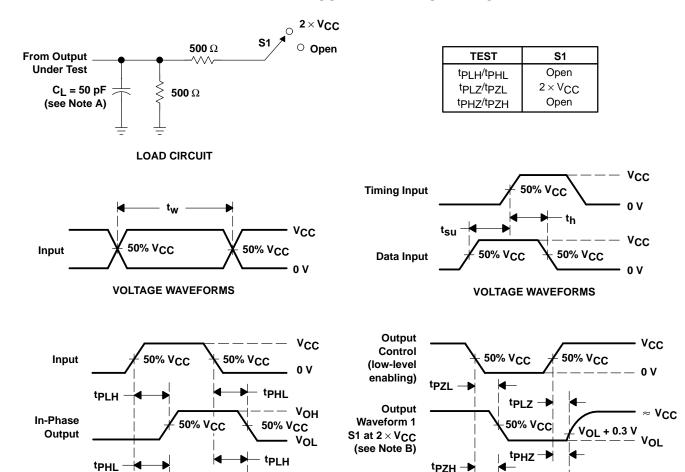
operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST COND	TYP	UNIT	
C _{pd}	Power dissipation capacitance	$C_{L} = 50 \text{ pF},$	f = 1 MHz	25	pF





PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

Out-of-Phase

Output

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

۷он

VOL

50% V_CC

50% V_{CC}

VOLTAGE WAVEFORMS

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.

tpzh -

50% V_{CC}

VOLTAGE WAVEFORMS

Output

Waveform 2

S1 at Open

(see Note B)

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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